Spin-O rbit Coupling, Antilocalization, and Parallel Magnetic Fields in Quantum Dots

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We investigate antilocalization due to spin-orbit coupling in ballistic G aAs quantum dots. Antilocalization that is prominent in large dots is suppressed in small dots, as anticipated theoretically. Parallel magnetic elds suppress both antilocalization and also, at larger elds, weak localization, consistent with random matrix theory results once orbital coupling of the parallel eld is included. In situ control of spin-orbit coupling in dots is demonstrated as a gate-controlled crossover from weak localization to antilocalization.

The combination of quantum coherence and electron spin rotation in mesoscopic systems produces a number of interesting and novel transport properties. Numerous proposals for potentially revolutionary electronic devices that use spin-orbit (SO) coupling have appeared in recent years, including gate-controlled spin rotators [1] as well as sources and detectors of spin-polarized currents [2]. It has been predicted that the elects of some types of SO coupling will be strongly suppressed in small OD systems, i.e., quantum dots [3, 4, 5]. This suppression as well as overall control of SO coupling will be important if quantum dots are used to store electron spin states as part of a future information processing scheme.

In this Letter, we investigate SO e ects in ballisticchaotic GaAs/A IGaAs quantum dots. We identify the signature of SO coupling in ballistic quantum dots to be antibocalization (AL), leading to characteristic magnetoconductance curves, analogous to known cases of disordered 1D and 2D systems [6, 7, 8, 9, 10, 11]. AL is found to be prominent in large dots and suppressed in sm aller dots, as anticipated theoretically [3, 4, 5]. Results are generally in excellent agreem entwith a new random m atrix theory (RMT) that includes SO and Zeem an coupling [5]. Moderate magnetic elds applied in the plane of the 2D electron gas (2D EG) in which the dots are form ed cause a crossover from AL to weak localization (WL). This can be understood as a result of Zeem an splitting, consistent with RMT [5]. At larger parallel elds W L is also suppressed, which is not expected within RMT. The suppression of W L is explained quantitatively by orbital coupling of the parallel eld, which breaks time-reversal symmetry [12]. Finally, we demonstrate in situ electrostatic control of the SO coupling strength by tuning from AL to WL in a dot with a center gate.

It is well known that in mesoscopic samples coherent backscattering of time-reversed electron trajectories leads to a conductance minimum (WL) at B=0 in the spin-invariant case, and a conductance maximum (AL) in the case of strong SO coupling [6]. In semiconductor heterostructures, SO coupling results mainly from electric elds [13] (appearing as magnetic elds in the electron frame) leading to momentum dependent spin precessions due to crystal inversion asymmetry (Dresselhaus term [14]) and heterointerface asymmetry (Rashba term [15]).

SO coupling e ects have been previously measured using AL in GaAs 2DEGs [8, 9, 10] and other 2D heterostructures [11]. Other means of measuring SO coupling in heterostructures, such as from Shubnikov-de Haas oscillations [16] and Ram an scattering spectroscopy [17] are also quite developed. SO e ects have also been reported in m esoscopic system s (com parable in size to the phase coherence length) such as Aharonov-Bohm rings, wires, and carbon nanotubes [18]. Recently, parallel eld e ects of SO coupling in quantum dots were measured [19, 20]. In particular, an observed reduction of conductance uctuations in a parallel eld [20] was explained by including SO e ects [4, 5], leading to an important extension of random matrix theory (RMT) to include new symmetry classes associated with SO and Zeem an coupling [5].

This RMT addresses quantum dots coupled to two reservoirs via N total conducting channels, with N It assumes  $(;_{Z})$  $E_T$ , where = N = (2 ) is the level broadening due to escape, is the mean level spacing,  $z = g_B B$  is the Zeem an energy and  $E_T$  is the Thouless energy (Table I). Decoherence is included as a ctitious voltage probe [5, 21] with dimensionless dephasing rate  $N_{i} = h = (i, j)$ , where i is the phase coherence time. SO lengths  $_{1;2}$  along respective principal axes [110] and [110] are assumed (within the RMT) to be large compared to the dot dimensions  $L_{1;2}$  along these axes. We do not he mean  $\underset{\text{so}}{\text{ength}}$   $\underset{\text{so}}{\text{so}}$  =  $p = \frac{p}{j_{1}} = \frac{p}{j_{1}} = \frac{p}{j_{2}}$  and SO anisotropy  $\underset{\text{so}}{\text{so}}$  =  $p = \frac{p}{j_{1}} = \frac{p}{j_{2}}$  SO coupling introduces two energy scales:  $^{\text{so}}_{?} = _{?} \text{E}_{\text{T}} (\text{L}_{1}\text{L}_{2} = ^{2}_{\text{so}})^{2}$ , which represents a spin-dependent Aharonov-Bohm-like  $((L_1 = 1)^2 + (L_2 = 2)^2)_2^{\text{so}}$ , providing spin ips. AL appears in the regime of strong SO coupling,  $\binom{so}{2}$ ;  $\binom{so}{k}$  ~, where ~ is the total level broadening  $\sim$  = ( + h=,). Note that large dots reach the strong SO regim e m ore readily (i.e., for weaker SO coupling) than sm all dots. Param eters  $_{\text{so}}$ , , and  $_{?}$  (a dim ensionless param eter characterizing trajectory areas within the dot) are extracted from ts to dot conductance as a function of perpendicular eld, B<sub>2</sub>. The asym metry parameter, so, is estimated from the dependence of magnetoconductance on parallel eld,  $B_k$ .

The quantum dots are formed by lateral Cr-Au de-

pletion gates de ned by electron-beam lithography on the surface of a G aA s/A IG aA s heterostructure grown in the [001] direction. The 2DEG interface is 349A below the wafer surface, com prising a 50 A G aAs cap layer and a 299A ALGaAs layer with two Si -doping layers 143A and 161A from the 2DEG.An electron density of  $10^{5}$  m<sup>2</sup> [22] and bulk mobility  $24 \, \text{m}^2 = V \, \text{s}$ (cooled in the dark) gives a transport mean free path 3 m. This 2DEG is known to show AL in 2D [10]. M easurem ents were made in a <sup>3</sup>He cryostat at 0:3K using current bias of 1 nA at 338 Hz. Shape-distorting gates were used to obtain ensembles of statistically independent conductance m easurem ents [23] while the point contacts were actively held at one fully transmitting mode each (N = 2).

Figure 1 shows average conductance hgi, and variance of conductance uctuations, var(g), as a function of B? for the three m easured dots: a large dot (A  $8 \text{ m}^2$ ), a variable size dot with an internal gate (A 5:8 m<sup>2</sup> or 8 m<sup>2</sup>, depending on center gate voltage), and a smaller dot (12 m<sup>2</sup>). Each data point represents 200 independent device shapes. The large dot shows AL while the sm alland gated dots show W L.E stim ates for so, , and ?, from RMT ts are listed for each device below the micrographs in Fig. 1 (see Table I for corresponding? and k). When AL is present (i.e., for the large dot), estim ates for so have sm all uncertainties ( 5% ) and give upper and lower bounds; when AL is absent (i.e., for the sm all and gated dots) only a lower bound for  $_{so}$  ( 5% ) can be extracted from ts. The value so 4:4 m is

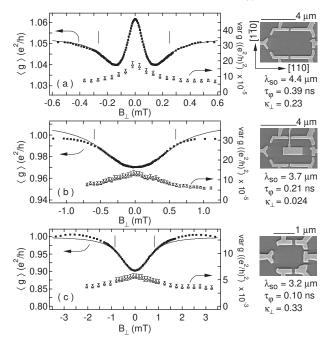


FIG. 1: A verage conductance hgi (squares) and variance of conductance var(g) (triangles) calculated from 200 statistically independent samples (see text) as a function of perpendicular magnetic eld B  $_{\rm 2}$  for (a) 8:0 m  $^2$  dot (b) 5:8 m  $^2$  center-gated dot and (c) 1:2 m  $^2$  dot at T = 0:3 K , along with ts to RMT (solid curves). In (b), the center gate is fully depleted. Vertical lines indicate the tting range, error bars of hgi are about the size of the squares.

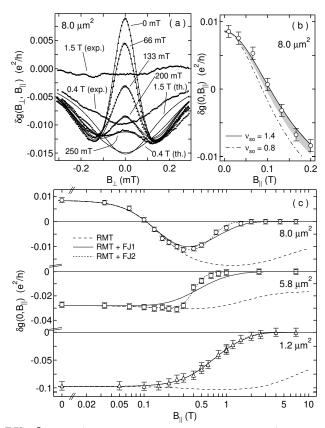


FIG. 2: (a) Dierence of average conductance from its value at large B  $_{?}$  , g(B  $_{?}$ ; B  $_{k}$ ), as a function of B  $_{?}$  for several B  $_{k}$  for the 8:0 m  $^{2}$  dot at T = 0:3 K (squares) with RMT ts (curves). (b) Sensitivity of g(0; B  $_{k}$ ) to  $_{so}$  for the 8:0 m  $^{2}$  dot, 1  $_{so}$  2 (shaded),  $_{so}$  = 1:4 (solid line) and  $_{so}$  = 0:8 (dashed line) (c) g(0; B  $_{k}$ ) (m arkers) with RMT predictions (dashed curves) and one parameter (solid curves) or two parameter ts (dotted curves) using RMT including a suppression factor due to orbital coupling of B  $_{k}$ , see text.

consistent with all dots and in good agreement with AL m easurements made on an unpatterned 2DEG sample from the samewafer [10].

C om paring Figs. 1(a) and 1(c), and recalling that all dots are fabricated on the same wafer, one sees that A L is suppressed in smaller dots, even though  $_{\rm SO}$  is su cient to produce A L in the larger dot. We note that these dots do not strongly satisfy the inequalities L=  $_{\rm SO}$  1; N 1, having N = 2 and L=  $_{\rm SO}$  = 0:64 (0:34) for the large (small) dot. Nevertheless, Fig. 1 shows the very good

Α		d	$E_T =$	*°=	k =	a 1, a2	$b_2$
${\rm m}^{-2}$	eV	ns				(ns) $^1$ T $^2$	(ns) 1 T 6
1.2	6.0	0.35	33	0.15	0.04	6.6, 6.6	0.24
			73			32,0	140
8	0.9	2.3	86	3 <b>.</b> 6	3.1	1.4,0.9	3.7

TABLE I: Dot area A =  $\rm L_1L_2$  (130 nm edge depletion); spin-degenerate mean level spacing = 2 h  $^2$ =m A (m =  $\rm p0.067m~e)$ ; dwell time  $\rm _d$  = h=(N ); Thouless energy E  $\rm _T$  = hv $\rm _F$  = A;  $\rm _?^{SO}$  = and  $\rm _k^{SO}$  = for the ts in Fig.1; B  $\rm ^2$  coe cients a  $\rm _1$  and a $\rm _2$  from one and two parameter ts; B  $\rm ^6$  coe cient b  $\rm _2$  from two parameter t, see text.

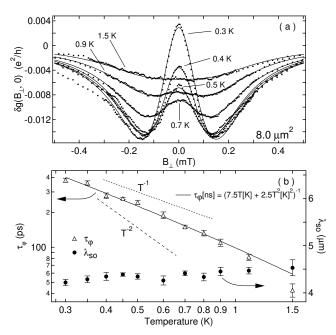


FIG. 3: (a) Dierence of average conductance from its value at large B  $_2$  , g(B  $_2$  ;0), for various temperatures with B  $_k$  = 0 for the 8:0 m  $^2$  dot (squares), along with RMT ts (solid curves). (b) Spinorbit lengths  $_{\rm SO}$  (circles) and phase coherence times  $^\prime$  (triangles) as a function of temperature, from data in (a).

agreem ent between experim ent and the new RMT.

We next consider the in wence of a parallel magnetic eld on average magnetoconductance. In order to apply tesla-scale B  $_{\rm k}$  while maintaining subgauss control of B  $_{\rm 2}$  , we mount the sample with the 2D EG aligned to the axis of the primary solenoid (accurate to -1) and use an independent split-coil magnet attached to the cryostat to provide B  $_{\rm 2}$  as well as to compensate for sample misalignment [20]. Figure 2 shows plots of the deviation of the shape-averaged conductance from its value at B  $_{\rm 2}$ 

 $_0\!=\!\!A$  (i.e., with time-reversal symmetry fully broken by B  $_2$  ),  $g(B_2;B_k)=hg(B_2;B_k)i$   $hg(B_2$   $_0\!=\!\!A;B_k)i.$  Figure 2(a) shows  $g(B_2;B_k)$  as a function of B  $_2$  at several values of B  $_k$  , along with ts of RM T [5] in which parameters  $_{so}$  , and  $_2$  have been set by a single t to the B  $_k$  = 0 data. The low-eld dependence of  $g(0;B_k)$  on B  $_k$  (Fig. 2(b)) then allows the remaining parameter,  $_{so}$ , to be estimated as described below .

Besides  $_{\rm Z}$  (which is calculated using g = 0:44 rather than t), parallel eld combined with SO coupling introduces an additional new energy scale,  $_{\rm Z}^{\rm Z}=\frac{2}{2E_{\rm T}}$  by  $_{\rm i;j=1;2}$   $\frac{l_{\rm i}}{i}$ , where  $_{\rm Z}$  is a dot-dependent constant and  $l_{\rm i;2}$  are the components of a unit vector along B  $_{\rm K}$  [5]. Because orbitale ects of B  $_{\rm K}$  on  $_{\rm G}$  (B  $_{\rm Z}$ ; B  $_{\rm K}$ ) dominate at large B  $_{\rm K}$ ,  $_{\rm Z}^{\rm Z}$  must instead be estimated from RMT ts of var(g) with already-broken time reversal symmetry, which is una ected by orbital coupling [24].

The RMT formulation [5] is invariant under  $_{so}$ !  $r=_{so}$ , where  $r=L_1=L_2$  [25], and gives an extremal value of  $g(0;B_k)$  at  $_{so}=$  r. As a consequence, ts to  $g(0;B_k)$  cannot distinguish between  $_{so}$  and  $r=_{so}$ . As

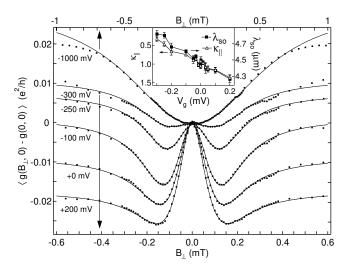
shown in Fig. 2(b), data for the 8 m $^2$  dot (r 2) are consistent with 1  $_{\rm so}$  2 and appear best t to the extrem al value,  $_{\rm so}$  1:4. Values of  $_{\rm so}$  that di er from one indicate that both R ashba and D resselhaus term s are signi cant, which is consistent with 2D data taken on the same m aterial [10].

U sing  $_{so}=1.4$  and values of  $_{so}$ , , and  $_{?}$  from the B  $_{k}=0$  t, RMT predictions for  $g(B_{?};B_{k})$  agree well with experiment up to about B  $_{k}=0.2$  T (Fig. 2(a)), showing a crossover from A L to W L. For higher parallel elds, however, experimental g's are suppressed relative to RMT predictions. By B  $_{k}=2$  T, W L has vanished in all dots (Fig. 2(c)) while RMT predicts signicant remaining W L at large B  $_{k}$ . The full range of  $g(0;B_{k})$  for the three dots is shown in Fig. 2(c). The center-gated (5:6 m  $^{2}$ ) dot and the small (1:2 m  $^{2}$ ) dot show W L for all B  $_{k}$ , and a similar suppression of W L above B  $_{k}=2$  T.

One would expect W L/AL to vanish once orbital effects of B k break time reversal symmetry. Following Ref. [12] (FJ), we account for this with a suppression factor  $f_{FJ}(B_k) = (1 + \frac{1}{B_k} = \frac{1}{esc})^{-1}$ , where  $\frac{1}{B_k}$  $aB_{\nu}^{2} + bB_{\nu}^{6}$ and assume that the combined elects of SO coupling and ux threading by  $B_k$  can be written as a product,  $g(0;B_k) = g_{M,T}(0;B_k)$  <sub>F</sub>f<sub>J</sub>(B<sub>k</sub>). The B<sub>k</sub><sup>2</sup> term reects surface roughness or dopant inhom ogeneities; the  $B_k^6$  term re ects the asym m etry of the quantum well. W e consider tstaking a as a tparameter (a1, Table I) with  $b = 1.410^8 s^1 T^6$  xed, obtained from self-consistent simulations [26], or allowing both a and b to be tparam eters ( $a_2$  and  $b_2$ , Table I). Figure 2(c) shows that allowing both to be free is only signicant for the (unusually shaped) center-gated dot; for the small and large dots, the single-param eter (a) t gives good quantitative agreem ent.

W e next consider the e ects of tem perature and dephasing. We not that increased temperature reduces the overall magnitude of g and also suppresses AL compared to W L, causing AL at 300 m K to become W L by 1.5K (maximum of  $g(B_?;0)$  at  $B_? = 0$  becomes minimum) in the 8 m<sup>2</sup> dot (Fig. 3a). Fits of RMT to g(B2;0) yield so values that are roughly independent of tem perature (Fig. 3b), consistent with 2D results [9], and values that decrease with increasing temperature. Dephasing is well described by the empirical form (, [ns]) 1 7:5T [K]+2:5 (T [K]), consistent with previous measurements in low-50 dots [27]. As temperature increases, long trajectories that allow large amounts of spin rotations are being cut o by the decreasing, and the AL peak is dim in ished, as observed.

Finally, we demonstrate in situ control of the SO coupling using a center-gated dot. Figure 4 shows the observed crossover from AL to WL as the gate voltage  $V_g$  is tuned from  $\pm 0.2\,\text{V}$  to  $\pm 1\,\text{V}$ . At  $V_g = \pm 1\,\text{V}$ , electrons beneath the center gate are fully depleted producing a dot of area 5.8 m² which shows WL. In the range of  $V_g = \pm 0.3\,\text{V}$ , the region under the gate is not fully depleted and the amount of AL is controlled by modifying the density under the gate. Note that for  $V_g > \pm 0.0\,\text{V}$  the



 $F\ IG$  . 4: Dierence of average conductance hgi from its value at B  $_2$  = 0 as a function of B  $_2$  for various center gate voltages  $V_g$  in the center-gated dot (squares), along with ts to RM T [5]. Good ts are obtained though the theory assumes hom ogeneous SO coupling. Error bars are the size of the squares. Inset:  $_{SO}$  and  $_k$  as a function of  $V_g$  extracted from RM T ts, see text.

AL peak is larger than in the ungated 8 m $^2$  dot. We interpret this enhancement not as a removal of the SO suppression due to an inhomogeneous SO coupling [28], which would enhance AL in dots with L= $_{\rm SO}$  1 (not

the case for the 8 m  $^2$  dot), but rather as the result of increased SO coupling in the higher-density region under the gate when  $V_{\rm q}>$  0 V .

Onemay wish to use the evolution of WL/AL as a function of  $V_{\rm q}$  to extract SO param eters for the region under the gate. To do so, the dependence may be ascribed to either a gate-dependent  $_{so}$  or to a gate-dependence of a new parameter  $_k$  =  $_k^{so}$ =((( $\mathbb{L}_1$ =  $_1$ ) $^2$  + ( $\mathbb{L}_2$ =  $_2$ ) $^2$ ) $_?^{so}$ ). Both options give equally good agreem ent with the data (ts in Fig. 4 assum  $e_{so}(V_q)$ ), including the parallel eld dependence (not shown). Resulting values for so or  $_{k}$  (assuming the other xed) are shown in the inset in Fig. 4. We note that the 2D samples from the same wafer did not show gate-voltage dependent SO param eters [10]. However, in the 2D case a cubic D resselhaus term that is not included in the RMT of Ref. [5] was signi cant. For this reason, ts using [5] m ight show  $_{so}$   $(V_{g})$  though the 2D case did not. Further investigation of the gate dependence of SO coupling in dots will be the subject of future work.

We thank I.A leiner, B.A ltshuler, P.B rouwer, J.C remers, V.Falko, J.Folk, B.Halperin, T. Jungwirth and Y.Lyanda-Geller. This work was supported in part by DARPA-QuIST, DARPA-SpinS, ARO-MURI and NSF-NSEC.W ork at UCSB was supported by QUEST, an NSF Science and Technology Center. JBM acknowledges partial support from NDSEG.

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